June 1997



SEMICONDUCTOR TM

# NDS336P

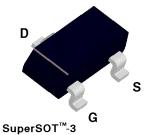
# P-Channel Logic Level Enhancement Mode Field Effect Transistor

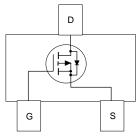
#### **General Description**

SuperSOT<sup>™</sup>-3 P-Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications such as notebook computer power management, portable electronics, and other battery powered circuits where fast high-side switching, and low in-line power loss are needed in a very small outline surface mount package.

# Features

- -1.2 A, -20 V,  $R_{DS(ON)} = 0.27 \ \Omega \ @ V_{GS} = -2.7 \ V$  $R_{DS(ON)} = 0.2 \ \Omega \ @ V_{GS} = -4.5 \ V.$
- Very low level gate drive requirements allowing direct operation in 3V circuits. V<sub>GS(th</sub>) < 1.0V.</li>
- Proprietary package design using copper lead frame for superior thermal and electrical capabilities.
- High density cell design for extremely low R<sub>DS(ON)</sub>.
- Exceptional on-resistance and maximum DC current capability.
- Compact industry standard SOT-23 surface Mount package.



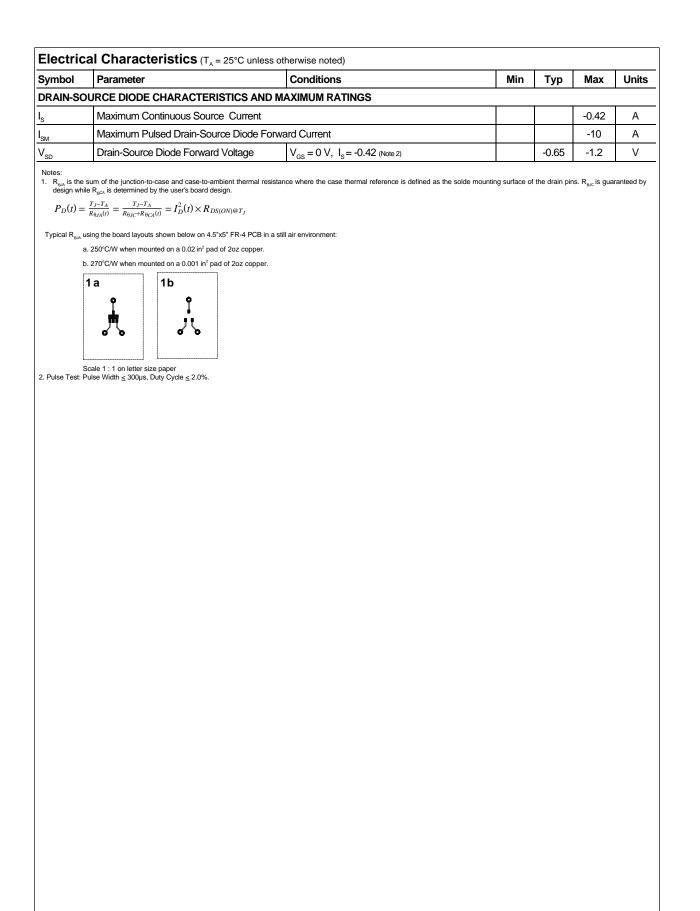


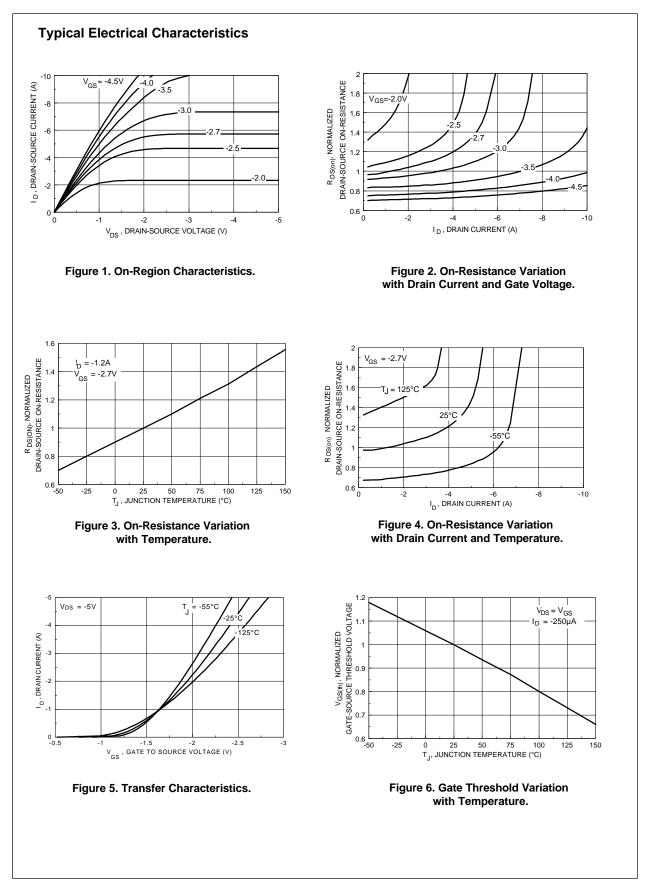
#### Absolute Maximum Ratings T<sub>a</sub> = 25°C unless otherwise noted

Symbol	Parameter		NDS336P	Units
V <sub>DSS</sub>	Drain-Source Voltage		-20	V
V <sub>GSS</sub>	Gate-Source Voltage - Continuous		±8	V
I <sub>D</sub>	Maximum Drain Current - Continuous	(Note 1a)	-1.2	А
	- Pulsed		-10	
P <sub>D</sub>	Maximum Power Dissipation	(Note 1a)	0.5	W
		(Note 1b)	0.46	
T_,T <sub>stg</sub>	Operating and Storage Temperature Range		-55 to 150	°C
THERMA	L CHARACTERISTICS			
R <sub>eja</sub>	Thermal Resistance, Junction-to-Ambient	(Note 1a)	250	°C/W
R <sub>ejc</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	75	°C/W

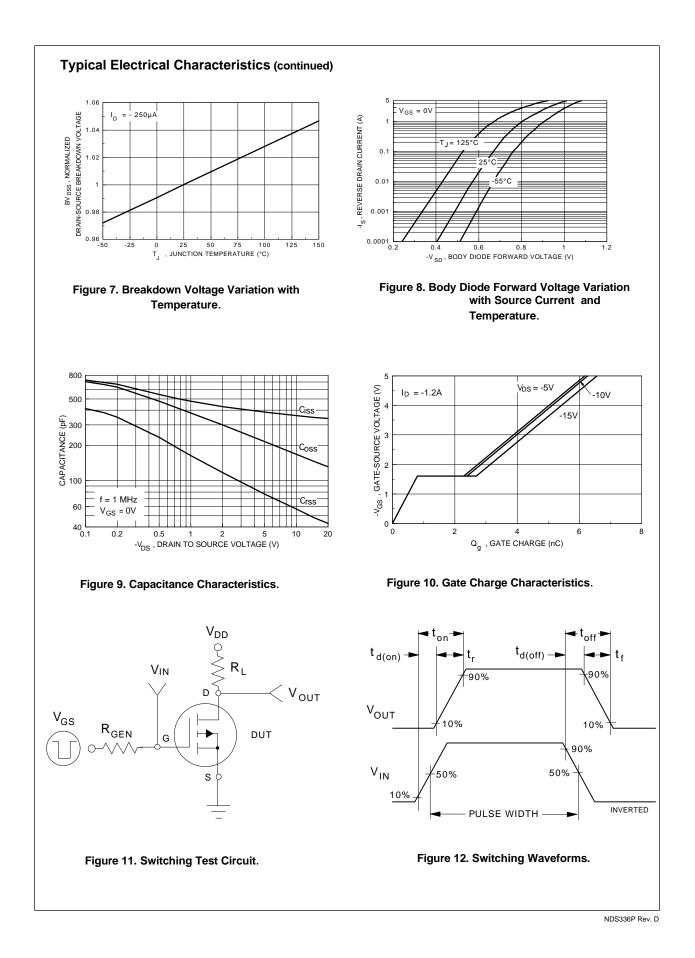
© 1997 Fairchild Semiconductor Corporation

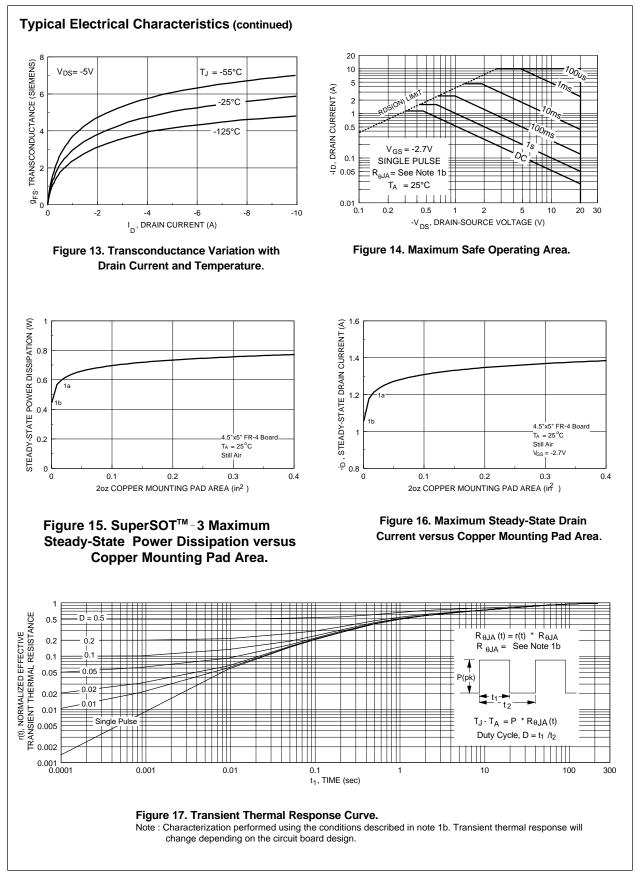
Symbol	Parameter	Conditions		Min	Тур	Max	Units
OFF CHA	RACTERISTICS	·			•		
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = -250 \mu A$		-20			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = -16 V, V_{GS} = 0 V$				-1	μA
			T <sub>J</sub> =55°C			-10	μA
I <sub>GSS</sub>	Gate - Body Leakage Current	$V_{GS} = 8 V, V_{DS} = 0 V$	·			100	nA
I <sub>GSS</sub>	Gate - Body Leakage Current	$V_{GS} = -8 V, V_{DS} = 0 V$				-100	nA
ON CHAR	ACTERISTICS (Note 2)						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{\rm DS} = V_{\rm GS}, I_{\rm D} = -250 \mu {\rm A}$		-0.5	-0.78	-1	V
			T <sub>J</sub> =125°C	-0.3	-0.58	-0.8	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = -2.7 V, I <sub>D</sub> = -1.2 A	·		0.22	0.27	Ω
()			T_=125°C		0.34	0.49	
		V <sub>GS</sub> = -4.5 V, I <sub>D</sub> = -1.3 A			0.16	0.2	1
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = -2.7 \text{ V}, V_{DS} = -5 \text{ V}$		-2			Α
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -5 V, I_{D} = -1.2 A$			-3		S
DYNAMIC	CHARACTERISTICS						
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -10 V, V_{GS} = 0 V,$ f = 1.0 MHz			360		pF
C <sub>oss</sub>	Output Capacitance				170		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				60		pF
SWITCHIN	IG CHARACTERISTICS (Note 2)						
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DD} = -5 V, I_{D} = -1 A,$			8	15	ns
ţ	Turn - On Rise Time	$V_{\rm GS}=-4.5~V,~R_{\rm GEN}=6~\Omega$			29	50	ns
t <sub>D(off)</sub>	Turn - Off Delay Time				33	60	ns
t,	Turn - Off Fall Time				23	45	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -1.2 \text{ A},$ $V_{GS} = -4.5 \text{ V}$			5.7	8.5	nC
Q <sub>gs</sub>	Gate-Source Charge				0.7		nC
Q <sub>gd</sub>	Gate-Drain Charge				1.8		nC





NDS336P Rev. D





NDS336P Rev. D

#### TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™ Bottomless™ CoolFET™ CROSSVOLT™ DenseTrench™ DOME™ **EcoSPARK™** E<sup>2</sup>CMOS<sup>™</sup> EnSigna™ FACT™ FACT Quiet Series™ FAST ® FASTr™ FRFET™ GlobalOptoisolator<sup>™</sup> POP<sup>™</sup> GTO™ HiSeC™ ISOPLANAR™ LittleFET™ MicroFET™ MicroPak™ MICROWIRE™

**OPTOLOGIC™** OPTOPLANAR™ PACMAN™ Power247™ PowerTrench<sup>®</sup> QFET™ QS™ QT Optoelectronics<sup>™</sup> Quiet Series<sup>™</sup> SILENT SWITCHER®

SMART START™ VCX™ STAR\*POWER™ Stealth™ SuperSOT<sup>™</sup>-3 SuperSOT<sup>™</sup>-6 SuperSOT<sup>™</sup>-8 SyncFET™ TinyLogic™ TruTranslation<sup>™</sup> UHC™ UltraFET<sup>®</sup>

STAR\*POWER is used under license

### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY. FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

# LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### **PRODUCT STATUS DEFINITIONS**

**Definition of Terms** 

Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.			
Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.			
Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.			
	In Design First Production Full Production			